

STGW10M65DF2

Trench gate field-stop IGBT, M series 650 V, 10 A low loss

Datasheet - production data

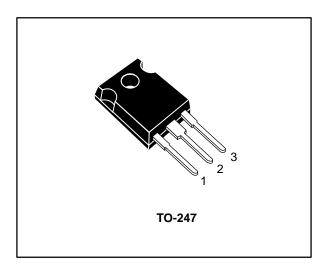
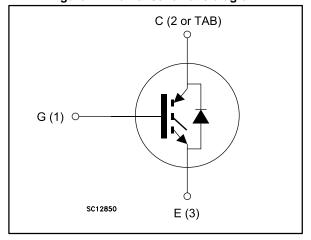


Figure 1: Internal schematic diagram



Features

- 6 µs of short-circuit withstand time
- V_{CE(sat)} = 1.55 V (typ.) @ I_C = 10 A
- Tight parameter distribution
- Safer paralleling
- Low thermal resistance
- Soft and very fast recovery antiparallel diode

Applications

- Motor control
- UPS
- PFC

Description

This device is an IGBT developed using an advanced proprietary trench gate field-stop structure. The device is part of the M series of IGBTs, which represent an optimum compromise in performance to maximize the efficiency of inverter systems where low-loss and short-circuit capability are essential. Furthermore, a positive $V_{\text{CE(sat)}}$ temperature coefficient and tight parameter distribution result in safer paralleling operation.

Table 1: Device summary

Order code	Marking	Package	Packing
STGW10M65DF2	G10M65DF2	TO-247	Tube

Contents STGW10M65DF2

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STGW10M65DF2 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vces	Collector-emitter voltage (V _{GE} = 0)	650	V
1.	Continuous collector current at T _C = 25 °C	20	۸
lc	Continuous collector current at T _C = 100 °C	10	Α
ICP ⁽¹⁾	Pulsed collector current	sed collector current 40	
V_{GE}	Gate-emitter voltage	± 20	V
	Continuous forward current at T _C = 25 °C	20	А
l _F	Continuous forward current at T _C = 100 °C	10	A
I _{FP} ⁽¹⁾	Pulsed forward current	40	Α
Ртот	Total dissipation at T _C = 25 °C	115	W
T _{STG}	Storage temperature range - 55 to 150		°C
TJ	Operating junction temperature range	- 55 to 175	

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
RthJC	Thermal resistance junction-case IGBT	1.3	
RthJC	Thermal resistance junction-case diode	2.08	°C/W
R _{thJA}	Thermal resistance junction-ambient	50	

 $^{^{(1)}}$ Pulse width limited by maximum junction temperature.

Electrical characteristics STGW10M65DF2

2 Electrical characteristics

 $T_C = 25$ °C unless otherwise specified

Table 4: Static characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)CES}	Collector-emitter breakdown voltage	V _{GE} = 0 V, I _C = 250 μA	650			V
		$V_{GE} = 15 \text{ V}, I_{C} = 10 \text{ A}$		1.55	2.0	
V _{CE(sat)} Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 10 A, T _J = 125 °C		1.9		V	
	V _{GE} = 15 V, I _C = 10 A, T _J = 175 °C		2.1			
		I _F = 10 A		1.5		
V _F	Forward on-voltage	I _F = 10 A, T _J = 125 °C		1.3		V
		I _F = 10 A, T _J = 175 °C		1.2		
V _{GE(th)}	Gate threshold voltage	V _{CE} = V _{GE} , I _C = 250 μA	5	6	7	V
ICES	Collector cut-off current	V _{GE} = 0 V, V _{CE} = 650 V			25	μΑ
I _{GES}	Gate-emitter leakage current	$V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$			250	μΑ

Table 5: Dynamic characteristics

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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{ies}	Input capacitance		-	840	-	
Coes	Output capacitance	$V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}, $ $V_{GE} = 0 \text{ V}$	-	63	ı	pF
Cres	Reverse transfer capacitance	VGL — V V	-	16	-	
Qg	Total gate charge	Vcc = 520 V, Ic = 10 A,	-	28	ı	
Q_{ge}	Gate-emitter charge	V _{GE} = 15 V (see <i>Figure 30</i> :	-	6	1	nC
Q_{gc}	Gate-collector charge	" Gate charge test circuit")	-	12	-	

Table 6: IGBT switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time			19	-	ns
tr	Current rise time			7.4	1	ns
(di/dt)on	Turn-on current slope	V _{CE} = 400 V, I _C = 10 A,		1086	-	A/µs
t _{d(off)}	Turn-off-delay time	$V_{GE} = 15 \text{ V}, R_G = 22 \Omega$		91	-	ns
t _f	Current fall time	(see Figure 29: " Test circuit for inductive load		92	-	ns
E _{on} ⁽¹⁾	Turn-on switching energy	switching")		0.12	-	mJ
E _{off} (2)	Turn-off switching energy			0.27	-	mJ
Ets	Total switching energy			0.39	-	mJ
t _{d(on)}	Turn-on delay time			18	-	ns
tr	Current rise time			9	-	ns
(di/dt) _{on}	Turn-on current slope	V _{CE} = 400 V, I _C = 10 A,		890	-	A/µs
t _{d(off)}	Turn-off-delay time	$V_{GE} = 15 \text{ V}, R_{G} = 22 \Omega$		90	-	ns
tf	Current fall time	T _J = 175 °C (see Figure 29: " Test circuit for		170	-	ns
Eon ⁽¹⁾	Turn-on switching energy	inductive load switching")		0.26	-	mJ
E _{off} (2)	Turn-off switching energy			0.4	-	mJ
E _{ts}	Total switching energy			0.66	-	mJ
t _{sc}	Short-circuit withstand time	Vcc ≤ 400 V, V _{GE} = 13 V, T _{Jstart} = 150 °C	10		-	
		V _{CC} ≤ 400 V, V _{GE} = 15 V, T _{Jstart} = 150 °C	6		-	μs

Notes:

Table 7: Diode switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{rr}	Reverse recovery time		-	96		ns
Qrr	Reverse recovery charge	I _F = 10 A, V _R = 400 V,	-	373		nC
I _{rrm}	Reverse recovery current	V _{GE} = 15 V (see <i>Figure 29:</i> "	-	13		Α
dl _{rr} /dt	Peak rate of fall of reverse recovery current during t _b	Test circuit for inductive load switching") di/dt = 1000 A/µs	-	661		A/µs
Err	Reverse recovery energy		-	52		μJ
t _{rr}	Reverse recovery time		-	201		ns
Qrr	Reverse recovery charge	I _F = 10 A, V _R = 400 V,	-	1352		nC
I _{rrm}	Reverse recovery current	$V_{GE} = 15 \text{ V T}_{J} = 175 \text{ °C}$ (see Figure 29: " Test circuit	-	19		Α
dl _{rr} /dt	Peak rate of fall of reverse recovery current during t _b	for inductive load switching") di/dt = 1000 A/µs	-	405		A/µs
Err	Reverse recovery energy		-	150		μJ

⁽¹⁾Including the reverse recovery of the diode.

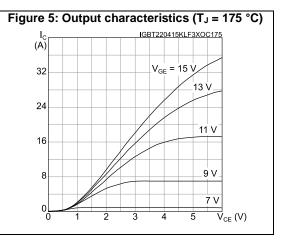
 $[\]ensuremath{^{(2)}}\mbox{Including}$ the tail of the collector current.

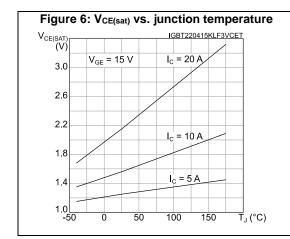
2.1 Electrical characteristics (curves)

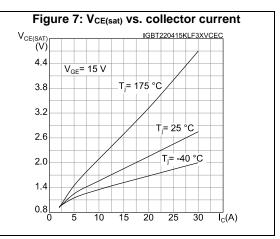
Figure 2: Power dissipation vs. case temperature

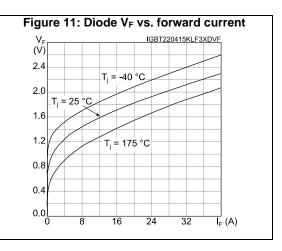
PTOT | GBT220415KLF3XPDT |

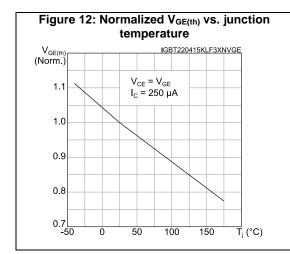
120 | 90 | $V_{GE} \ge 15 \text{ V}$ $T_j \le 175 \text{ °C}$ 30 | $T_c \text{ (°C)}$

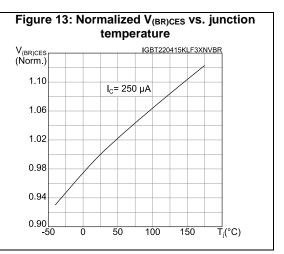












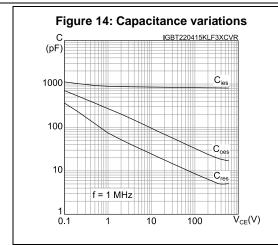


Figure 15: Gate charge vs. gate-emitter voltage

V_{GE}
(V)

16

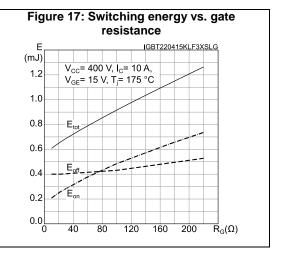
V_{CC} = 520 V,
I_C = 10 A,
I_G = 1 mA

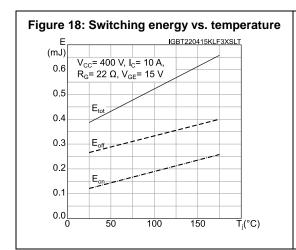
12

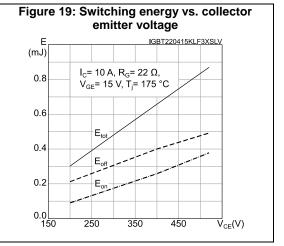
8

4

0
0
0
5
10
15
20
25
30
Q_g (nC)

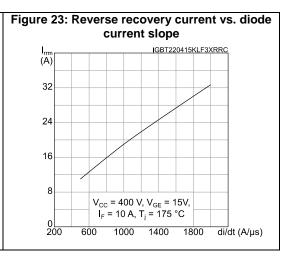


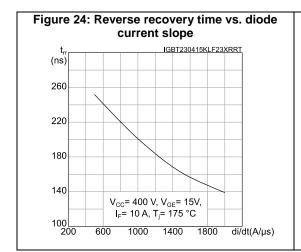


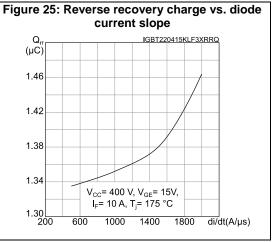


STGW10M65DF2 Electrical characteristics

Figure 20: Short-circuit time and current vs. V_{GE} IGBT220415KLF3XSCV I_{SC} (A) (µs) V_{CC}≤ 400 V 65 20 T_i≤ 150 °C 15 50 10 35 20 5 $\overrightarrow{V}_{GE}(V)$ 12 13 14 15







Electrical characteristics STGW10M65DF2

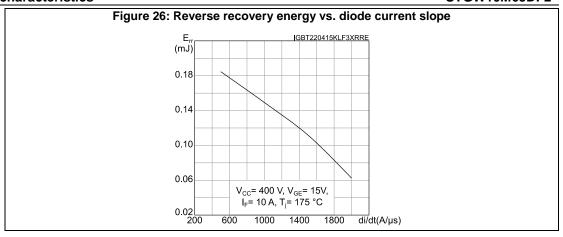


Figure 27: Thermal impedance for IGBT

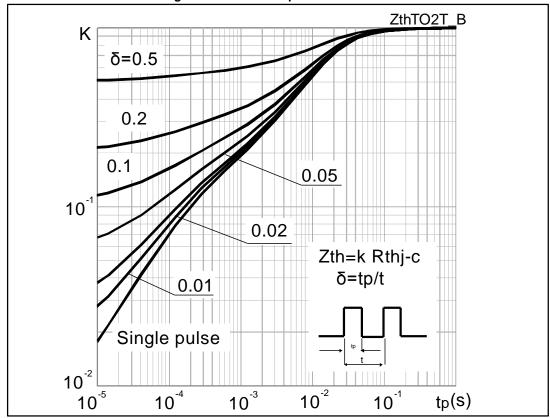
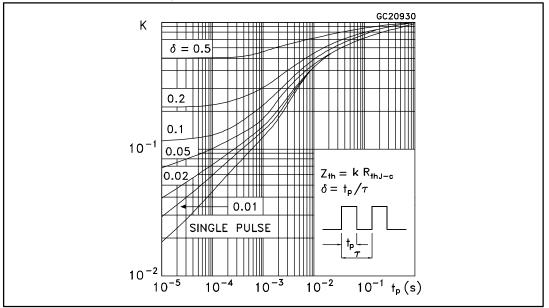
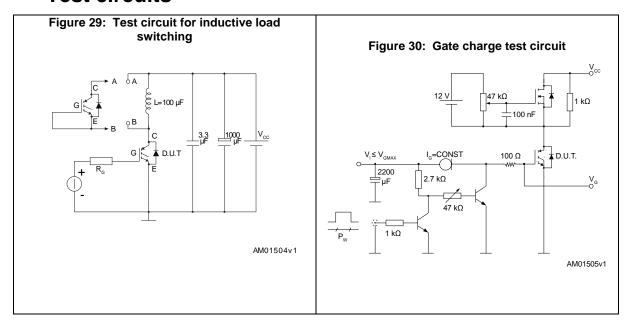


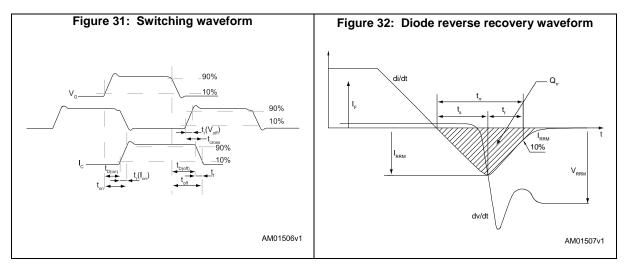
Figure 28: Thermal impedance for diode



Test circuits STGW10M65DF2

3 Test circuits





4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-247 package information

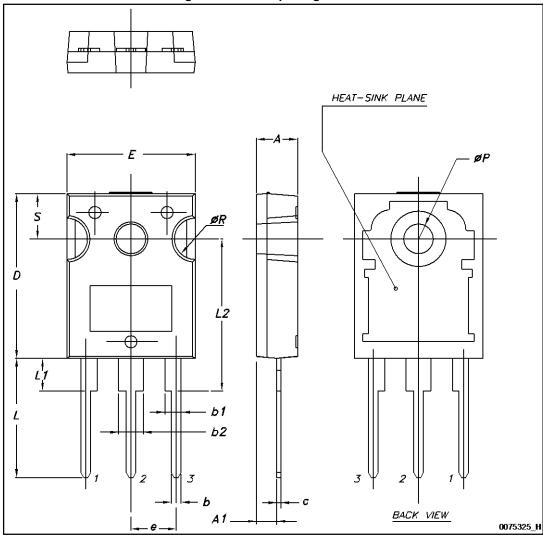


Figure 33: TO-247 package outline

Table 8: TO-247 package mechanical data

Dim.	•	mm.	
Dilli.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
Е	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

STGW10M65DF2 Revision history

5 Revision history

Table 9: Document revision history

Date	Revision	Changes
08-Mar-2016	1	First release.

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